

40V N-SGT Enhancement Mode MOSFET

Ø APM

General Description

APG120N04NF use advanced SGT MOSFET technology to provide low RDS(ON), low gate charge, fast switching and excellent avalanche characteristics.

This device is specially designed to get better ruggedness and suitable to use in

Features

Low RDS(on) & FOM

Extremely low switching loss

Excellent stability and uniformity or Invertors

Applications

Consumer electronic power supply

Motor control

Synchronous-rectification

Isolated DC

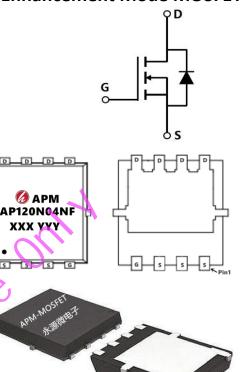
Synchronous-rectification applications

Package Marking and Ordering Inform

Package Marking and Ordering Information			
Product ID	Pack	Marking	Qty(PCS)
APG120N04NF	PDFN5*6-8L	APG120N04NF XXX YYYY	5000

Absolute Maximum Ratings at T_i=25°C unless otherwise noted

Symbol	Parameter Rating		Units	
Vos	Drain-Source Voltage	40	V	
Vgs	Gate-Source Voltage	Gate-Source Voltage ±20		
I _D @Tc=25℃	Continuous Drain Current, V _{GS} @ 10V ^{1,6}	120	А	
1 _D @Tc=100°C	Continuous Drain Current, V _{GS} @ 10V ^{1,6}	82	А	
Ідм	Pulsed Drain Current ²	400	А	
EAS	Single Pulse Avalanche Energy ³	400	mJ	
las	Avalanche Current	40	А	
P _D @T _C =25°C	Total Power Dissipation ⁴	125	W	
Тѕтс	Storage Temperature Range	-55 to 150	℃	
TJ	Operating Junction Temperature Range	-55 to 150	℃	
Reja	Thermal Resistance Junction-Ambient ¹	50	°C/W	
Rejc	Thermal Resistance Junction-Case ¹	1	°C/W	







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Electrical Characteristics at T_i=25 °C unless otherwise specified

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	40			V
		V _{GS} =10V , I _D =20A		1.4	1.8	
RDS(ON)	Static Drain-Source On-Resistance ²	V _{GS} =4.5V , I _D =20A		2.0	2.6	mΩ
VGS(th)	Gate Threshold Voltage	$V_{GS}=V_{DS}$, $I_D=250uA$	1.2	1.6	2.2	V
		V _{DS} =32V , V _{GS} =0V , T _J =25°C	E		1	
IDSS	Drain-Source Leakage Current	V _{DS} =32V , V _{GS} =0V , T _J =55°C			5	uA
IGSS	Gate-Source Leakage Current	V _{GS} =±20V , V _{DS} =0V			±100	nA
gfs	Forward Transconductance	V _{DS} =5V , I _D =20A		53		S
Rg	Gate Resistance	V _{DS} =0V , V _S =0V , f=1MHz		1.0		Ω
Qg	Total Gate Charge (4.5V)			45		
Qgs	Gate-Source Charge	V _{DS} =15V , V _{GS} =10V , I _D =20A		12		nC
Qgd	Gate-Drain Charge	le		18.5		
Td(on)	Turn-On Delay Time			18.5		
Tr	Rise Time	V _{DD} =15V , V _{GS} =10V , R _G =3.3 ,		9		
Td(off)	Turn-Off Delay Time	I _D =20A		58.5		ns
Tf	Fall Time	10-20/		32		
Ciss	Input Capacitance			3972		
Coss	Output Capacitance	V _{DS} =20V , V _{GS} =0V , f=1MHz		1119		pF
Crss	Reverse Transfer Capacitance			82		
IS	Continuous Source Current ^{1,6}	V _G =V _D =0V , Force Current			100	А
VSD	Diode Forward Voltage ²	V_{GS} =0 V , I_{S} =1 A , T_{J} =25 $^{\circ}$ C			1.2	V

Note:

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2 .The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%
- 3. The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V, L=0.5mH, I_{AS} =40A
- 4. The power dissipation is limited by 150°C junction temperature
- 5 .The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



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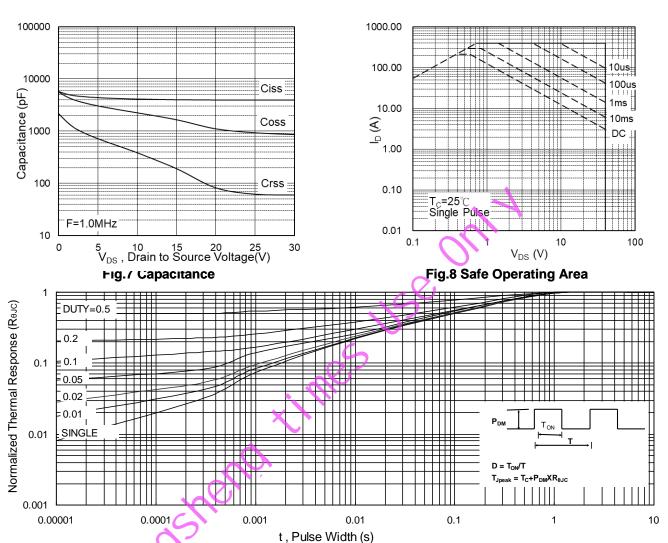


Fig.9 Normalized Maximum Transient Thermal Impedance

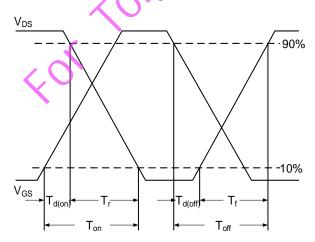


Fig.10 Switching Time Waveform

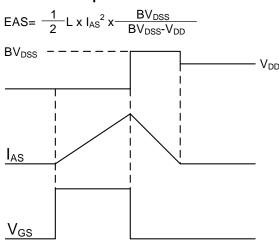
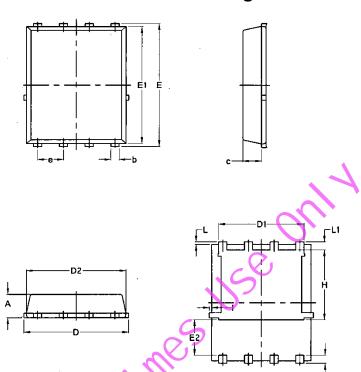


Fig.11 Unclamped Inductive Switching Waveform



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Package Mechanical Data-DFN5*6-8L-JQ Single



	Common				
Symbol	mm		Inch		
	Mim	Max	Min	Max	
А	1.03	1.17	0.0406	0.0461	
b	0.34	0.48	0.0134	0.0189	
С	0.824	0.0970	0.0324	0.082	
D	4.80	5.40	0.1890	0.2126	
D1	4.11	4.31	0.1618	0.1697	
D2	4.80	5.00	0.1890	0.1969	
E	5.95	6.15	0.2343	0.2421	
E 1	5.65	5.85	0.2224	0.2303	
E2	1.60	/	0.0630	/	
е	1.27 BSC		0.05 BSC		
L	0.05	0.25	0.0020	0.0098	
L1	0.38	0.50	0.0150	0.0197	
L2	0.38	0.50	0.0150	0.0197	
Н	3.30	3.50	0.1299	0.1378	
I	/	0.18	/	0.0070	



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